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Substitute for form 1449A/B/PTO  <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)				<b>Complete if Known</b>		
				Application Number	Unassigned	
Sheet		1	of	1	Filing Date	January 7, 2004
					First Named Inventor	Francesco DE REGE THESAURO
					Group Art Unit	Unassigned
					Examiner Name	Unassigned
					Attorney Docket Number	100185
					LVM Reference Number	220650

U.S. PATENT DOCUMENTS						
Examiner Initials	Doc. No.	U.S. Patent Document		Name of Patentee or Applicant	Date of Publication	Filing Date if Appropriate
		Application or Patent Number	Kind Code			
BM	AA	5,489,233		Cook et al.	Feb. 6, 1996	
	AB	5,527,423		Neville et al.	Jun. 18, 1996	
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	AN	2002/0090820	A1	Sun et al.	Jul. 11, 2002	
	AO	2002/0102923	A1	Sugiyama et al.	Aug. 1, 2002	
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	AQ	2003/0013387	A1	Tsai et al.	Jan. 16, 2003	
	AR	2003/0119319	A1	Sinha et al.	Jun. 26, 2003	

FOREIGN PATENT DOCUMENTS								
Examiner Initials	Doc. No.	Foreign Patent Document			Name of Patentee or Applicant	Date of Publication	Translation	
		Office	Application or Patent Number	Kind Code			Yes	No**
BM	AS	JP	63096599	A2	Mitsubishi Heavy Ind. Co. Ltd.	Apr. 27, 1988		X*
	AT	JP	11121411 ✓	A2	Matsushita Electronics Corp.	Apr. 30, 1999		X*
	AU	JP	01270512 ✓	A2	Tanaka Kikinzoku Kogyo KK	Oct. 27, 1989		X*
	AV	WO	00/77107 ✓	A1	Infineon Technologies AG	Dec. 21, 2000		X*
	AW	WO	01/44396 ✓	A1	Rodel Holdings, Inc.	Jun. 21, 2001		
	AX	WO	02/063669 ✓	A2	Applied Materials, Inc.	Aug. 15, 2002		
	AY	WO	03/064551 ✓	A1	EKC Technology, Inc.	Aug. 7, 2003		

OTHER - NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Doc. No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number (s), publisher, city and/or country where published.		
BM	AZ ✓	BUXTON et al., "Critical Review of Rate Constants for Reactions of Hydrated Electrons, Hydrogen Atoms and Hydroxyl Radicals (OH/O-) in Aqueous Solution," J. Phys. Chem. Ref. Data 17: 513-531 (1988)		

Examiner Signature	<i>Ball</i>	Date Considered	2/15/06
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\* A concise statement of relevance is being submitted in lieu of a translation. 37 CFR 1.98(a)(3).

+ An English-language equivalent/patent, or an English-language abstract, or an English-language version of the search report or action by a foreign patent office in a counterpart foreign application indicating the degree of relevance found by the foreign office is being submitted in lieu of a concise explanation of relevance under 37 CFR 1.98(a)(3).

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